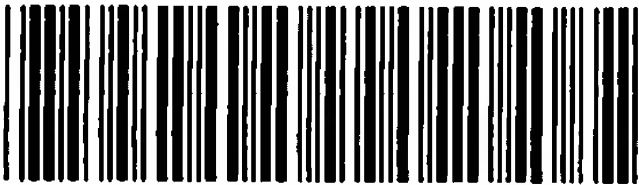


<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/638,233	ISHIDA ET AL.	
	<b>Examiner</b>	<b>Art Unit</b>	
	Haresh Patel	2154	

SEARCHED			
Class	Subclass	Date	Examiner
709	220	5/7/2007	H.P.
709	217-219	5/7/2007	H.P.
709	200-203	5/7/2007	H.P.
709	221-226	5/7/2007	H.P.
719	310-314	5/7/2007	H.P.
719	321,328	5/7/2007	H.P.

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East, US-PAT, US-PUB, EPO, JPO, IEEE Xplore, ACM Digital Library, Google	5/7/2007	H.P.
Consulted 101 Panel, Mr. John Follansbee	5/7/2007	H.P.